

Structure and thermoelectric properties of the n-type clathrate $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ [†]

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We study type I clathrate $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ single crystals (space group $Pm\bar{3}n$, no. 223, $a = 10.7151(3)$) grown using a Sn flux method. Microprobe analysis and single-crystal X-ray diffraction reveal a small amount of Sn embedded in the Cu/Ge framework, which increases disorder at the guest Ba sites. $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ is diamagnetic with a susceptibility of $\sim 2.8 \times 10^{-7} \text{ emu g}^{-1}$ and shows metal-like behavior ($dp/dT > 0$) with a low charge carrier concentration of 0.5 e^- per unit cell at 300 K. The single crystals show a relatively high carrier mobility (μ (300 K) = $11.9 \text{ cm}^2 \text{ V}^{-1}$) and very low lattice thermal conductivity ($\sim 0.6 \text{ W m}^{-1} \text{ K}^{-1}$). The thermoelectric figure of merit ZT of $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ single crystals reaches a maximum value of 0.6 at 773 K, which can be further improved by adjusting the chemical composition.

1 Introduction

It is known that intermetallic type I clathrates have low lattice thermal conductivity, which can be attributed to the interaction of the heat-carrying phonons with local vibration modes of guest atoms, so-called rattling, within the covalently bonded host framework.^{1–4} The electrical transport properties of clathrates are mainly controlled by the framework atoms and depend strongly on the chemical composition as well as the amount and distribution of defects in the framework. This makes the clathrates very suitable candidates for “phonon glass electron crystal” and opens up the possibility of optimizing their thermoelectric performance by tuning the composition.^{1,2}

Ba-containing clathrates have been widely studied as prospective thermoelectric materials.^{2,3} The parent compound, binary $\text{Ba}_8\text{Ge}_{43}$, is not directly useful in thermoelectric applications because of its high charge carrier concentration as can be seen from the electronic balance $[\text{Ba}^{2+}]_8[(3b)\text{Ge}^-]_{12}[(4b)\text{Ge}^0]_{31} + 4\text{e}^-$.^{5,6} In order to optimize the thermoelectric performance, a third component has been introduced into the framework to tune the electronic band structure and reduce the carrier concentration. Until now, clathrates with nominal

composition $\text{Ba}_8\text{T}_x\text{Ge}_{46-x-y}$ ($\text{T} = \text{Ga, Zn, Cd, Ni, Pd, Pt, Cu, Ag, and Au}$) have been studied by various groups.^{7–21} Among these clathrates, the highest thermoelectric figure of merit ZT that has been obtained is 1.35 at 900 K in the Czochochalski-grown $\text{Ba}_8\text{Ga}_{16}\text{Ge}_{30}$ single crystal.¹⁸ For type I clathrates with transition metals, their ZT s have been found to be relatively low. Recently, a study by X. Shi *et al.* shows that a Ba–Ga–Ge clathrate with slight Ni and Zn doping presents a high ZT of 1.2 at 1000 K.²² M. Falmbigl *et al.* report that Sn substitution in Ba-containing germanium-based clathrates can reduce the lattice thermal conductivity and therefore enhance the ZT values.^{23,24} Relatively high ZT values of 0.82 at 850 K and 0.9 at 830 K have been achieved in Ba–Zn–Ge–Sn and Ba–Ni–Zn–Ge–Sn clathrates, respectively.^{23,24}

Cordier and Woll⁷ reported $\text{Ba}_8\text{Cu}_6\text{Ge}_{40}$ as the first clathrate I phase in the $\text{Ba}_8\text{Cu}_x\text{Ge}_{46-x}$ system. Li *et al.* subsequently reported that the preferred composition of the Cu content is close to 5 per cell.²⁵ Johnsen *et al.* showed that $\text{Ba}_8\text{Cu}_x\text{Ge}_{46-x}$ is homogeneous in the range $0 < x \leq 0.7$ and such systems have large Seebeck coefficient, low thermal conductivity, and n-type conduction with a carrier mobility ($\mu = 8\text{--}10 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$) higher than those of clathrates containing transition metals.^{2,8} These results suggest that $\text{Ba}_8\text{Cu}_x\text{Ge}_{46-x}$ clathrates may have a good thermoelectric performance at high temperature. However, the only high temperature thermoelectric data that have been published are by Yan *et al.*²⁶ in the $\text{Ba}_8\text{Cu}_5\text{Si}_x\text{Ge}_{41-x}$ system, where $\text{Ba}_8\text{Cu}_5\text{Ge}_{41}$ shows a ZT of ~ 0.4 at about 390 °C. To date, the transport properties of Ba–Cu–Ge clathrates have only been studied in polycrystalline samples, where they are strongly affected by grain boundaries.

The single crystals of type I clathrates that have been studied are mostly $\text{Ba}_8\text{Ga}_{16}\text{Ge}_{30}$, $\text{Sr}_8\text{Ga}_{16}\text{Ge}_{30}$, and $\text{Ba}_8\text{Zn}_8\text{Ge}_{38}$, where

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elements with low melting temperature (Ga, Zn, Sn *etc.*) can be used as self-flux. For the ones containing transition metal elements with higher melting points, only $\text{Ba}_8\text{Ni}_{3.5}\text{Ge}_{42.1}$ and $\text{Ba}_8\text{Au}_{5.3}\text{Ge}_{40.7}$ single crystals have been grown using the Bridgman method, but they have low ZT values (≤ 0.3).^{20,21} In this paper, we use a simple Sn flux method to grow single crystals of type I clathrate $\text{Ba}_8\text{Cu}_{5.3}\text{Ge}_{40.7}$. Their crystalline structure, physical properties, and thermoelectric properties will be discussed. We focus on the subtle relation between disorder in the crystalline structure and the thermoelectric properties.

2 Experimental section

Synthesis

Polycrystalline samples of the nominal composition $\text{Ba}_8\text{Cu}_{5.3}\text{Ge}_{40.7}$ were synthesized in an Ar-filled glovebox [$p(\text{O}_2, \text{H}_2\text{O}) \leq 1$ ppm]. The stoichiometric mixtures of Ba pieces (99.9% metal basis), Cu grains (99.99%), and Ge grains (99.999%) were melted on a water-cooled copper hearth in a radio frequency (RF) induction furnace, and cooled down within a few minutes to room temperature. The ingots were put into quartz tubes with additional flux Sn, and then evacuated and sealed. The atomic ratio of Sn to Ba is about 20 to 8. The quartz tube was heated to 1000 °C in 10 hours, kept for 12 hours, and then cooled to 650 °C at a speed of 1 °C hour⁻¹. At this temperature, the quartz tube was removed from the furnace and the flux was removed from the crystal by centrifuging. The crystal we obtained is shown in Fig. 1.

During the growth experiment, a one-step method was also tested. The stoichiometric mixtures of Ba pieces (99.9% metal basis), Cu grains (99.99%), Ge grains (99.999%), and Sn flux were directly put into the quartz tube without the RF induction process, which also leads to similar crystals. Other flux, such as Ga, was used to grow a $\text{Ba}_8\text{Cu}_{5.3}\text{Ge}_{40.7}$ single crystal, but the obtained crystals tend to be $\text{Ba}_8\text{Ga}_{16}\text{Ge}_{30}$.

After the growth, the single crystals were evacuated and sealed in quartz tubes, and then annealed at 700 °C for three days before measuring the properties. Only the samples grown by the two-step method were used for property studies in this manuscript.

Powder X-ray diffraction

Powder X-ray diffraction patterns were recorded using 0.498103(2) Å synchrotron radiation. The wavelength was determined using

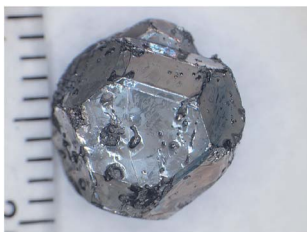


Fig. 1 Photograph of a $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ single crystal.

CeO_2 as the standard ($a = 5.411102$ Å). The fine powders were mounted in the ϕ 0.2 mm glass capillaries. Data were recorded using the large Debye-Scherrer camera with an imaging plate detector on the BL02B2 beamline at the Spring-8 synchrotron radiation research facility. Unit cell dimensions were determined using a least-squares technique with the program package GSAS.^{27,28} The calculated unit cell parameters for two single crystals are given in Table 1.

Crystal structure investigation

Synchrotron radiation X-ray single crystal diffraction measurements were carried out at the BL02B1 beamline of the Spring-8 synchrotron radiation research facility. The wavelength was calibrated to be 0.353848 Å also using CeO_2 as the standard. Each side of the single crystal was less than 20 μm . Nine frames of diffraction images were taken at 20 K (lowest temperature in the system) by a cryogenic He flowing system (XR-HR10K-S, Japan Thermal Engineering Co. Ltd). The oscillation angle of the crystal (ω) in each frame was 10°. The crystal structure refinement was made by employing a full-matrix least-squares procedure with the program package WinGX.³⁰ Details concerning the data collection and structure refinement are given in Table 2.

The single crystal diffraction data between 100 K and 400 K were collected using a rotating anode diffraction system Rigaku MERCURY CCD R-Axis IV (Mo radiation, $\lambda = 0.71075$ Å) at Institute for Molecular Science. Absorption correction was performed by a multiscan procedure.

Microstructure analysis

Energy dispersive X-ray spectroscopy (EDXS) was performed using the Si (Li) detector of an EDAX system (Gemsis Software V 4.61) on different parts of each crystal, which confirms the homogeneous composition of the samples. The composition was calculated from the measured intensities of the X-ray lines Ba L, Cu K, Ge K and Sn L caused by the electron beam at a 25 kV acceleration voltage. The standard-less method using the 2 AF matrix correction shows that the composition is $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ where it is assumed that there are 8 Ba atoms per formula unit.

Table 1 Lattice parameters of $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ single crystals in comparison with literature values for polycrystalline samples

Composition	$a/\text{\AA}$	Ref.
$\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$		
Crystal I	10.71540(3)	This work
Crystal II	10.71484(2)	This work
$\text{Ba}_8\text{Cu}_6\text{Ge}_{40}$	10.6859(8)	7
$\text{Ba}_8\text{Cu}_{5.3}\text{Ge}_{40.7}$	10.69145(5)	8
$\text{Ba}_8\text{Cu}_6\text{Ge}_{40}$	10.6894(2)	8
$\text{Ba}_8\text{Cu}_{4.5}\text{Ge}_{40.9}$	10.6952(2)	9
$\text{Ba}_8\text{Cu}_6\text{Ge}_{40}$	10.6903(2)	9
$\text{Ba}_8\text{Cu}_6\text{Ge}_{40}$	10.6850(1)	10
$\text{Ba}_8\text{Cu}_2\text{Ge}_{44}$	10.6987(1)	25
$\text{Ba}_8\text{Cu}_6\text{Ge}_{40}$	10.6872(2)	25
$\text{Ba}_8\text{Cu}_6\text{Ge}_{40}$	10.7492(5)	29

Table 2 Crystallographic data of $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ at 20 K

Composition	$\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$
Molar mass	4424.72 g mol ⁻¹
$a/\text{\AA}$	10.6742(10)
Unit cell volume/ \AA^3	1216.2(2)
Z ; $\rho_c/\text{g cm}^{-3}$	1; 6.041
Radiation, wavelength $\lambda/\text{\AA}$	Fine-focus sealed tube, 0.35385
Monochromator	Graphite
T/K	20(2)
μ/mm^{-1}	33.265
$F(000)/e$	1916
Absorption correction	Multi-scan
Reflections collected; independent	6874; 844 [$R_{\text{int}} = 0.034$]
Refinement method	Full-matrix least-squares on F
Refined parameters	23
Residuals [$I > 2\sigma(I)$]	$R = 0.022$, $wR = 0.030$
Residuals (all data)	$R = 0.039$, $wR = 0.031$
Goodness-of-fit on F	1.017
Extinction coefficient	0.00000(15)

Differential scanning calorimetry

DSC measurements were performed with a Netzsch DSC 404C instrument. About 20 mg of the sample were sealed in Nb ampoules (ϕ 5mm). The system was heated under an Ar atmosphere from room temperature to 1273 K by applying a heat rate of 10 K min⁻¹. $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ is found to melt congruently at $T = 911(4)^\circ\text{C}$.

Physical properties

The hall coefficient (R_H) and the heat capacity (C_p) from 2 K to 350 K were measured using a Quantum Design physical properties measurement system (PPMS). The carrier concentration was calculated *via* $n = 1/(eR_H)$, where e is the electron charge. The electrical conductivity σ and Seebeck coefficient S were measured in the temperature range from 300 to 823 K using a ZEM-3 instrument (ULVAC-RIKO). The magnetization of the crystals was measured using a Quantum Design superconducting quantum interference device (SQUID) in the temperature range 2 K to 400 K. The background signal of the holder was subtracted and the magnetic susceptibility χ was calculated *via* $\chi = (M(5T) - M(2T))/3T$.

The thermal diffusivity α was determined in the temperature range 300 K to 823 K using the laser flash technique (LFA 457 Micro Flash, Netzsch). The thermal conductivity κ was derived using the relationship $\kappa = C_p d \alpha$, where d is the sample density. C_p above room temperature was estimated based on the Petit-Dulong law with $C_p = 3NR/M$, where N is the number of atoms per formula unit, M is the molar mass, and R is the gas constant. No correction for thermal expansion was applied.

The electronic contribution κ_e to the thermal conductivity was calculated using the Wiedemann-Franz law $\kappa_e = L\sigma T$, where L is the Lorenz number which is obtained from the accepted approach of fitting the Seebeck data to the reduced chemical potential.³¹ The lattice thermal conductivity κ_L was obtained by subtracting the electronic thermal contribution from the total thermal conductivity.

Calculation procedure

The calculations are based on the density functional theory (DFT) in the generalized gradient approximation (GGA) with the Perdew-Burke-Ernzerhof (PBE) functional,³² as implemented in the Vienna *ab initio* Simulation Package (VASP).^{33,34} The plane-wave energy cutoff is set to be 500.00 eV, and the electronic energy convergence is 10^{-5} eV. A Γ -centered $5 \times 5 \times 5$ Monkhorst-Pack k -point mesh is used to sample the irreducible Brillouin zone.

3 Results and discussion

From PXRD data, the lattice constant a of the single crystals is found to be in the range 10.7148 to 10.7154 \AA at room temperature. The average value $a = 10.7151(3) \text{\AA}$ is significantly larger than the previously reported value of $\text{Ba}_8\text{Cu}_6\text{Ge}_{40}$ (see Table 1).^{8-10,25} The PXRD pattern of a ground single crystal is shown in Fig. 2. The reflection intensities are in good agreement with the structure model derived from single-crystal diffraction data.

The refinement of the crystal structure was performed using synchrotron single-crystal X-ray diffraction data collected at 20 K. In the first step of the structure refinement, the structure model of Cordier and Woll with the overall composition $\text{Ba}_8\text{Cu}_6\text{Ge}_{40}$ and all six Cu atoms at the 6c site was applied.⁷ After refinement of the anisotropic displacement parameters, fairly good values $R(F) = 0.051$ and $wR(F) = 0.067$ were obtained. The anisotropic displacement parameters of the Ba2 atoms were very large. An off-centered model (a quarter-occupied 24k site instead of a fully occupied 6d site) was used to reduce these parameters, giving $R(F) = 0.038$ and $wR(F) = 0.0445$. As Sn atoms may occupy some cage sites according to the chemical analysis, the cage sites were described by the mixed occupation of Ge (Cu) and Sn, which leads to $R(F) = 0.035$ and $wR(F) = 0.017$. However, the composition strongly deviates from the results obtained by chemical analysis. The final atomic parameters are shown in Table 3.

To study the vibrational properties and the disorder on each site, the on-center model was employed to analyze the single crystal diffraction data from 400 K to 100 K. The atomic

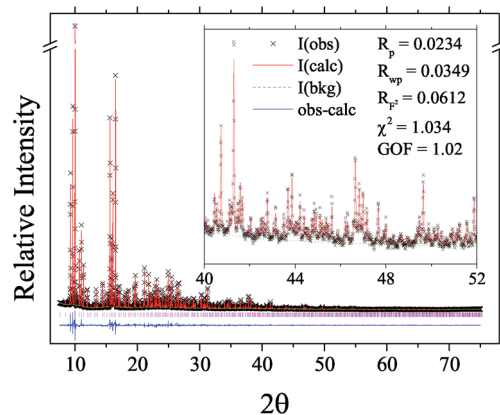
**Fig. 2** Powder X-ray diffraction pattern of $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$.

Table 3 Fractional atomic coordinates, site occupancies, and isotropic (U_{eq}) and anisotropic (U_{ij}) atomic displacement parameters of $Ba_8Cu_{5.1}Ge_{40.2}Sn_{0.7}$

Atom	Site	x	y	z	Occupancy	$U_{eq}/\text{\AA}^2$
Ba1	2a	0	0	0	1	0.0054(1)
Ba2	24i	0	0.498(2)	0.243(1)	0.25	0.0200(4)
Cu1/Ge1	6c	0.2500	0.5000	0	0.85/0.15	0.00321(1)
Ge2	16i	0.18323(2)	x	x	1.000	0.00202(6)
Ge3/Sn3	24k	0.11986(3)	0.31465(3)	0	0.97/0.03	0.00341(6)
Atom	U_{11}	U_{22}	U_{33}	U_{23}	U_{13}	U_{12}
Ba1	0.00540(11)	U_{11}	U_{11}	0	0	0
Ba2	0.0076(6)	0.0428(15)	0.0095(17)	0.0133(18)	0.000	0.000
Cu1/Ge1	0.0051(3)	0.00226(19)	0.00226(19)	0.000	0.000	0.000
Ge2	0.00202(6)	U_{11}	U_{11}	-0.00041(7)	U_{23}	U_{23}
Ge3/Sn3	0.00412(14)	0.00383(13)	0.00229(13)	0.000	0.000	0.00142(13)

displacement parameter (ADP) U for all atoms linearly decreases with decreasing temperature as shown in Fig. 3. The temperature dependences of U_{eq} for the guest Ba atom and the framework atoms are respectively written as

$$U_{ii}(\text{Ba}) = \frac{\hbar^2}{2mk_B\theta_{E,ii}} \coth\left(\frac{\theta_E}{2T}\right) + d^2, \quad (1)$$

$$U_{eq}(\text{cage}) = \frac{3\hbar^2 T}{mk_B\theta_E^2} \left[\frac{T}{\theta_D} \int_0^{\theta_D/T} \frac{x}{\exp(x)-1} dx + \frac{\theta_D}{4T} \right] + d^2, \quad (2)$$

where θ_E , θ_D and d^2 are the Einstein temperature for the Ba atoms, the Debye temperature for the framework atoms, and the temperature-independent disorder term, respectively. The fits with these equations yield the characteristic temperatures $\theta_E(\text{Ba1}) = 97$ K, and $\theta_E(\text{Ba2}) = 60$ K, and the Debye temperature of the framework $\theta_D \sim 230$ K. The rattling of Ba atoms located in the 6c site (Ba2) exhibits significant anisotropy as can also be seen in Fig. 3. The fitting parameters for the temperature dependence of U_{11} and U_{22} ($U_{22} = U_{33}$) of Ba2 atoms are listed in Table 4. The Einstein temperatures are consistent with those found in previous works,^{8,29} but the disorder of this site in our single crystal is much larger, which may be attributed to the increasing disorder strength in the cage framework resulting from slight Sn doping. From the lattice parameters vs. T shown in the inset of Fig. 3, the coefficient of thermal expansion has been estimated to be $1.18(3) \times 10^{-4} \text{ \AA K}^{-1}$.

The band structure calculation has been performed based on the structure analysis (Fig. 4). The basic band structure of the nominal composition $Ba_8Cu_6Ge_{40}$ is almost the same as the one found in ref. 8. The band gap at the M point is 0.23 eV, slightly larger than the previous result. Substituting Sn for Ge shows little influence on the band, but substituting one Sn atom for Cu at the 6c site (5 Cu/1 Sn) increases the Fermi level and changes the carrier type from holes to electrons.

The heat capacity consists of the electronic contribution $C_e = \gamma T$ and the lattice contribution C_l . The latter one is usually treated as a sum of a Debye term originating from the cage framework and an Einstein term arising from the localized

vibrational modes of the guest Ba atoms.^{35,36} The heat capacity can be written as eqn (3)

$$C_p = C_e + C_l = \gamma T + \frac{12\pi^4 N_D k_B}{5} \int_0^{\theta_D/T} \frac{x^4 e^x dx}{(e^x - 1)^2} + \sum_i p_i N_{E_i} R \left(\frac{\theta_{E_i}}{T} \right)^2 \frac{e^{\theta_{E_i}/T}}{(e^{\theta_{E_i}/T} - 1)^2}, \quad (3)$$

where $x = \hbar\omega/k_B T$ with \hbar being the reduced Planck constant and k_B being the Boltzmann constant, θ_D and N_D are the Debye temperature and the number of Debye oscillators per formula unit, and p_i , N_{E_i} and θ_{E_i} are the degrees of freedom, the number

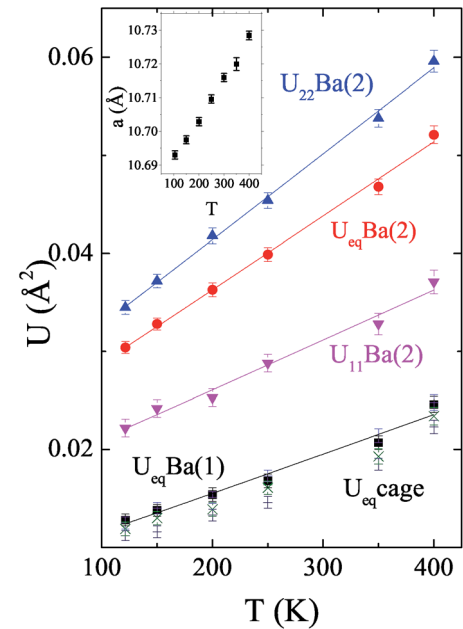


Fig. 3 The atomic displacement parameter U as a function of temperature for $Ba_8Cu_{5.1}Ge_{40.2}Sn_{0.7}$. Triangles pointing up are $U_{22}(\text{Ba2})$, circles are $U_{eq}(\text{Ba2})$, inverted triangles are $U_{11}(\text{Ba2})$, squares are $U_{eq}(\text{Ba1})$, and others are U_{eq} for cage framework atoms. The inset is the lattice parameters as a function of temperature.

Table 4 Einstein temperature (θ_E) and temperature-independent disorder parameters (d) of $\text{Ba}_8\text{Cu}_x\text{Ge}_{46-x}$ clathrates. SC stands for the single crystals investigated in this paper

	SC	$\text{Ba}_8\text{Cu}_6\text{Ge}_{40}$ (ref. 8)	$\text{Ba}_8\text{Cu}_6\text{Ge}_{40}$ (ref. 29)
$a(\text{\AA})$	10.7148	10.6894(2)	10.7492(5)
$\theta_{E,11}$ (K)	83(2)	92(2)	82(2)
$\theta_{E,22}$ (K)	63(1)	64(1)	63(1)
$d_{E,11}$ (\AA)	0.125(3)	0.097(4)	0.080(2)
$d_{E,22}$ (\AA)	0.154(2)	0.080(2)	0.109(1)

of Einstein oscillators, and the Einstein temperature of the i th vibrational mode, respectively.

At low temperatures, where the Einstein contribution is very small, the data can be understood using the electronic contribution and the Debye contribution following $C_p = \gamma T + \beta T^3$. The data below 5 K are plotted in Fig. 5, and a fit of the data below 4.4 K gives $\gamma = 2.57 \text{ mJ mol}^{-1} \text{ K}^{-2}$ and $\beta = 4.67 \text{ mJ mol}^{-1} \text{ K}^{-4}$. The resulting Debye temperature $\theta_D \sim 270 \text{ K}$ is higher than the result from fitting the atomic displacement parameter, but is comparable to previous reports.^{21,35} To emphasize the Einstein contribution, the data are replotted as “ C_p/T^3 vs. $\log T$ ” in the inset of Fig. 5. The contribution of the Einstein term appears as a pronounced peak center at $\sim 10 \text{ K}$. As the U factors for the 2a Ba atoms are quite to those for the cage atoms (see Fig. 3), these atoms are also considered to be Debye oscillators, like the cage framework atoms. Thus, only the Ba atoms at the 6c site can be viewed as Einstein-like oscillators. Besides, the anisotropic vibrations of the 6d atoms shown in Fig. 3 suggest that two vibrational modes are needed to described the two in-plane (θ_{E22}) and one out-of-plane (θ_{E11}) motions. The degrees of freedom and the numbers of oscillators are then given as $P_{E22} = 2$, $P_{E11} = 1$, and $N_{E22} = N_{E11} = 6$, respectively. With $\theta_D = 270 \text{ K}$ obtained from the low temperature C_p data, the best fit to reproduce the peak in Fig. 5 gives $\theta_{E22} = 60 \text{ K}$ and $\theta_{E11} = 80 \text{ K}$, which are consistent with those deduced from our diffraction data.

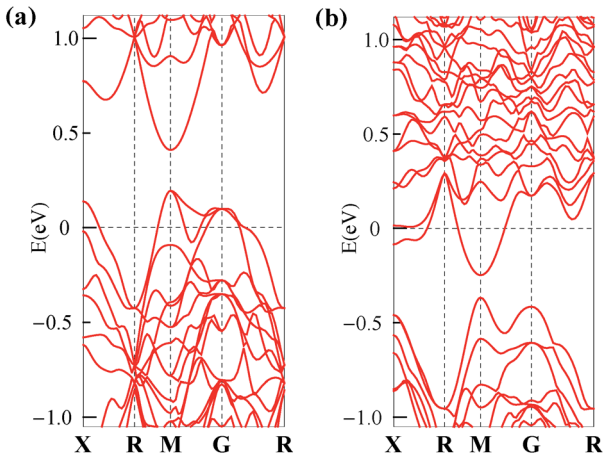


Fig. 4 Calculated band structures of (a) $\text{Ba}_8\text{Cu}_6\text{Ge}_{40}$ and (b) $\text{Ba}_8\text{Cu}_5\text{Ge}_{40}\text{Sn}$.

The M versus H results for the $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ single crystal at 2 K are shown in the inset of Fig. 6. A clear linear dependence is observed, in contrast to what was found using polycrystalline samples.²⁵ The magnetic susceptibility $\chi \approx -2.82 \times 10^{-7} \text{ emu g}^{-1}$ is much smaller than the value reported previously.^{10,25} To minimize the influence from impurities, the χ values at different temperatures are calculated from the magnetization difference between $2T$ and $5T$ as shown in Fig. 6. At low temperature, a weak Curie-law-like upturn toward low temperature is observed, indicating the presence of Curie-paramagnetic unpaired spins from the impurities or magnetic point defects. Above $\sim 50 \text{ K}$, χ increases slightly with temperature from $-2.88 \times 10^{-7} \text{ emu g}^{-1}$ at 50 K to $-2.77 \times 10^{-7} \text{ emu g}^{-1}$ at 400 K, which may be attributed to the increase of Pauli contribution due to higher carrier concentration at higher temperature.

The carrier concentration and Hall mobility as functions of temperature are presented in Fig. 7. The carrier concentration shows a slightly linear increase with temperature, indicating intrinsic and impurity band excitations. At room temperature, the carrier concentration is $4.42 \times 10^{20} \text{ cm}^{-3}$, which corresponds to 0.5 e^- per unit cell. It is higher than the values reported by Johnsen *et al.* in $\text{Ba}_8\text{Cu}_x\text{Ge}_{46-x}$,⁸ but close to the ones of $\text{Ba}_8\text{Ga}_x\text{Cu}_y\text{Ge}_{46-x-y}$ presented by Anno *et al.*³⁷ For the Zintl-like electron count, $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ here is written as $[\text{Ba}^{2+}]_8[(4b)\text{Cu}^{3-}]_{5.1}[(4b)\text{Ge}^0]_{40.2}[(4b)\text{Sn}^0]_{0.7} + 0.7 \text{ e}^-$. Thus, $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ should have a charge concentration of 0.7 e^- per unit cell, which is very close to the experimentally observed result (0.5 e^- per unit cell). The Hall mobility μ_H of the $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ single crystal decreases with increasing temperature. At room temperature, the value is $11.9 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$. Even though the slight Sn doping increases the disorder degree of both cage framework and Ba sites, the Hall mobility in our single crystal with a higher carrier concentration is still higher than the values in polycrystalline $\text{Ba}_8\text{Cu}_x\text{Ge}_{46-x}$ reported before.⁸ In view of the fact that the Ba-Cu-Ge clathrates have higher carrier mobility than other Ba-TM-Ge clathrates (TM = transition metal)^{2,8} and the mobility enhancement by Cu doping in $\text{Ba}_8\text{Ga}_{16}\text{Ge}_{30}$ clathrates,³⁷ it seems that Cu substitution in a Ba-Ge clathrate system is beneficial in increasing the carrier

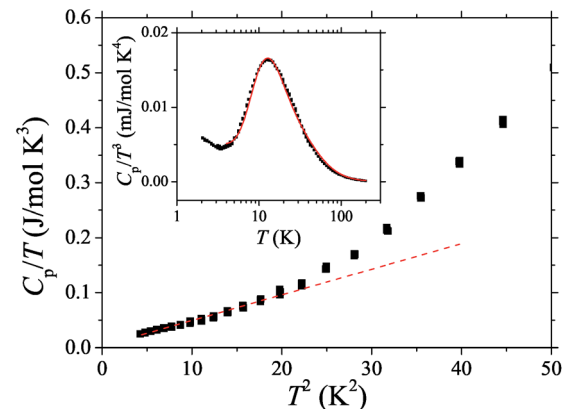


Fig. 5 The heat capacity of a $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ single crystal.

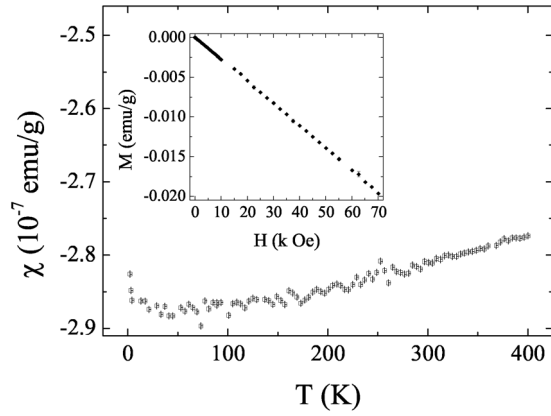


Fig. 6 The temperature dependence of magnetic susceptibility for the $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ single crystal. The inset is the field dependence at 2 K.

mobility, which is very important to improve the thermoelectric performance.

The temperature dependent resistivity, Seebeck coefficient, power factor, thermal conductivity, and ZT of the single crystal are shown in Fig. 8. The electrical resistivity increases with temperature as is typical in a degenerate semiconductor. The resistivity at room temperature is $0.74 \text{ m}\Omega \text{ cm}$. In the whole measured temperature range that has been studied, the Seebeck coefficient is negative, which suggests that the electrons dominate the electrical conduction, in agreement with Hall coefficient measurement. The absolute value of the Seebeck coefficient increases with increasing temperature to a maximum value of $-153 \text{ }\mu\text{V K}^{-1}$ at 773 K . At high temperatures, the decrease of thermopower with temperature probably originates from the thermal excitation of minority carriers across the band gap. The width of band gap E_g is estimated as $E_g = 2eS_{\text{max}}T(S_{\text{max}})$ from the maximum absolute thermopower value S_{max} and the temperature $T(S_{\text{max}})$ at which the maximum occurs. For $T(S_{\text{max}}) = 773 \text{ K}$ and $S_{\text{max}} = -153 \text{ }\mu\text{V K}^{-1}$, we obtain a band-gap width of 0.236 eV and it is consistent with the calculated value for the $\text{Ba}_8\text{Cu}_6\text{Ge}_{40}$ composition. The power factor (S^2/ρ) increases with temperature to a maximum value of $10 \text{ }\mu\text{W cm}^{-1} \text{ K}^{-2}$ at 723 K and then reduces significantly.

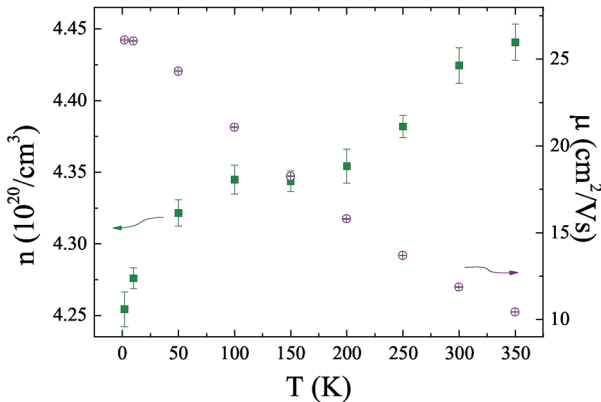


Fig. 7 Carrier concentration and Hall mobility of $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$.

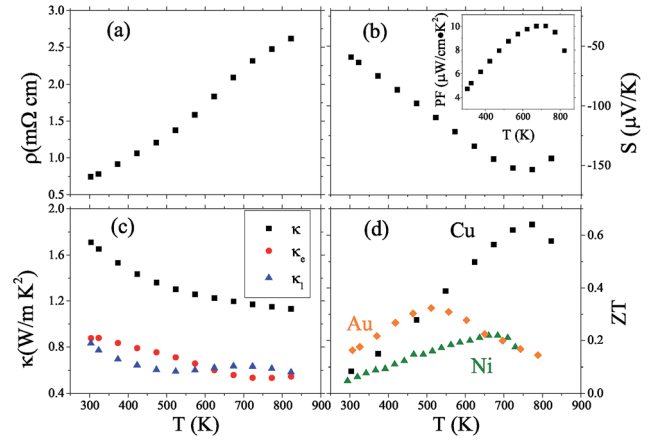


Fig. 8 Thermoelectric properties of $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$ single crystals. (a) Resistivity, (b) Seebeck coefficient, (c) thermal conductivity, and (d) ZT . Au and Ni represent the data of $\text{Ba}_8\text{Au}_{5.3}\text{Ge}_{40.7}$ and $\text{Ba}_8\text{Ni}_{3.5}\text{Ge}_{42.1}$ single crystals from previous studies,^{20,21} respectively.

The total thermal conductivity decreases with temperature from $1.7 \text{ W m}^{-1} \text{ K}^{-2}$ at 300 K to $1.1 \text{ W m}^{-1} \text{ K}^{-2}$ at 823 K . The lattice thermal conductivity is obtained by subtracting the electronic contribution from the total thermal conductivity. Above room temperature, the lattice thermal conductivity reduces to approximately $0.6 \text{ W m}^{-1} \text{ K}^{-1}$ around 500 K , and is more or less unchanged at higher temperatures. This minimum lattice thermal conductivity of $\sim 0.6 \text{ W m}^{-1} \text{ K}^{-2}$ is lower than the previously reported value in $\text{Ba}_8\text{Ni}_{3.5}\text{Ge}_{40.1}$ single crystals,²⁰ which could be attributed to the increased disorder degree in the cage framework of the Ba sites. Nevertheless, this value is still higher than that of a $\text{Ba}_8\text{Ga}_{16}\text{Ge}_{30}$ single crystal with large randomness of Ga/Ge displacement in the cage framework.¹⁸ ZT reaches a maximum value of 0.6 at 773 K . This value is much higher than those of $\text{Ba}_8\text{Au}_{5.3}\text{Ge}_{40.7}$ or $\text{Ba}_8\text{Ni}_{3.5}\text{Ge}_{42.1}$ single crystals. With further carrier concentration optimization or phonon engineering, the ZT value of the type I Ba-Cu-Ge clathrate could be improved at high temperatures.

4 Conclusions

We have successfully synthesized Ba-Cu-Ge clathrate single crystals using the Sn-flux method. A small amount of Sn was found in the lattice and the real composition is $\text{Ba}_8\text{Cu}_{5.1}\text{Ge}_{40.2}\text{Sn}_{0.7}$. The single crystal is diamagnetic with χ to $-2.8 \times 10^{-7} \text{ emu g}^{-1}$ between 2 K and 400 K . It is a degenerated semiconductor with a carrier concentration of 0.5 e^- per unit cell. Both the band structure calculations and the experimental data suggest that the band gap is about 0.23 eV . The slight Sn doping in the cage framework increases the disorder degree at the Ba sites, which gives rise to a low lattice thermal conductivity ($0.6 \text{ W m}^{-1} \text{ K}^{-2}$ above 500 K) but the Hall mobility ($11.9 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ at room temperature) is not strongly influenced. The maximum ZT value of the single crystal was found to be 0.6 at 773 K .

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